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Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

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Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









ITS41k0S-ME-N

Smart High-Side NMOS-Power Switch

Data Sheet

Rev 1.0, 2012-09-01

Standard Power



Smart High-Side NMOS-Power Switch

ITS41k0S-ME-N



1 Overview

Features

- Current controlled input
- Capable of driving all kind of loads (inductive, capacitive and resitive)
- · Negative voltage clamped at output with inductive loads
- Current limitation
- Very low standby current
- · Thermal shutdown with restart
- Overload protection
- Short circuit protection
- · Overvoltage protection (including load dump)
- Reverse battery protection
- Loss of GND and loss of Vbb protection
- ESD-Protection
- Improved electromagnetic compatibility (EMC)
- Green Product (RoHS compliant)

ITS41k0S-ME-N is not qualified and manufactured according to the requirements of Infineon Technologies with regards to automotive and/or transportation applications.

Description

The ITS41k0S-ME-N is a protected 1 Ω single channel Smart High-Side NMOS-Power Switch in a PG-SOT223-4 package with charge pump and current controlled input, monolithically integrated in a smart power technology.

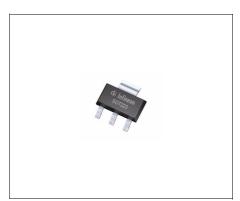
Product Summary

Overvoltage protection $V_{\rm SAZ~min}$ = 62V Operating voltage range 4,9V < $V_{\rm S}$ < 60V On-state resistance $R_{\rm DSON}$ typ 800 m Ω Operating Temperature range Tj = -40°C to 125°C

Application

- All types of resistive, inductive and capacitive loads
- · Current controlled power switch for 12V, 24V and 45V DC in industrial applications
- Driver for electromagnetic relays
- Signal amplifier

Туре	Package	Marking
ITS41k0S-ME-N	PG-SOT223-4	I1k0SN



PG-SOT223-4



Block Diagram and Terms

2 Block Diagram and Terms

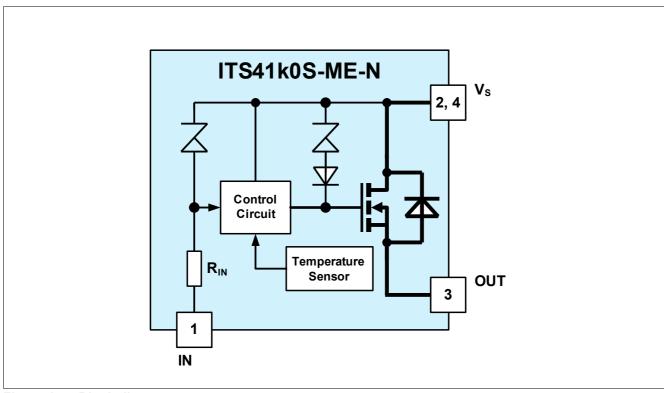


Figure 1 Block diagram

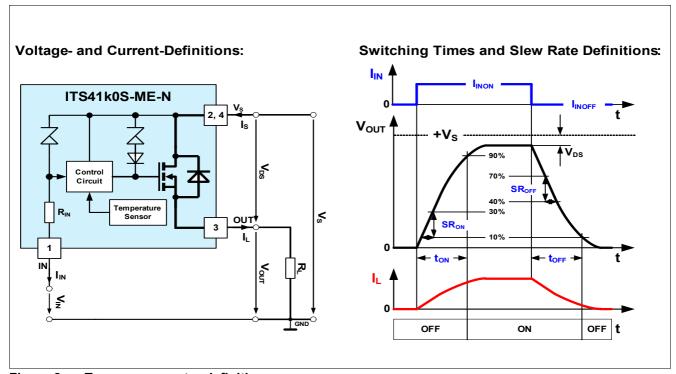


Figure 2 Terms - parameter definition



Pin Configuration

3 Pin Configuration

3.1 Pin Assignment

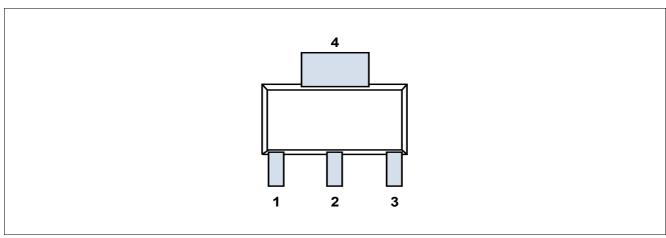


Figure 3 Pin configuration top view, PG-SOT223-4

3.2 Pin Definitions and Functions

Pin	Symbol	Function
1	IN	Input, activates the power switch in case of connection to GND
2	VS	Supply voltage
3	OUT	Output to the load
4	VS	Supply voltage



General Product Characteristics

4 General Product Characteristics

4.1 Absolute Maximum Ratings

Table 1 Absolute maximum ratings ¹⁾Tj = 25°C all voltages with respect to ground.

Currents flowing into the device unless otherwise specified in chapter "Block Diagram and Terms"

Parameter	Symbol	Values			Unit	Note /
		Min.	Тур.	Max.		Test Co ndition
Supply voltage VS			-			•
Voltage	V_{S}		60	V		4.1.1
Output stage OUT		-	·	<u> </u>	-	<u>, </u>
Output Current; (Short circuit current see electrical characteristics)	I_{OUT}	self limi	ted		А	4.1.2
Input IN						
Input Current	I_{IN}	-15	15	mA		4.1.3
Temperatures						
Junction Temperature	T_{j}	-40	125	°C		4.1.4
Storage Temperature	T_{stg}	-55	125	°C		4.1.5
Power dissipation			·			
Ta = 25 °C ²⁾	P_{tot}		1.7	W		4.1.6
Inductive load switch-off energy dissipate	tion	·	·	•	•	•
Tj = 150 °C; IL=0.15A; single pulse 1)	E_{AS}		1000	mJ		4.1.7
ESD Susceptibility	•	·			·	•
ESD susceptibility (input pin)	V_{ESD}	-1	1	kV	HBM ³⁾	4.1.8
ESD susceptibility (all other pins)	V_{ESD}	-5	5	kV	HBM ³⁾	4.1.9

¹⁾ Not subject to production test, specified by design

Note: Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" the normal operating range. Protection functions are not designed for continuous or repetitive operation.

²⁾ Device on 50mm*50mm*1.5mm epoxy PCB FR4 with 6 cm2 (one layer, 70mm thick) copper area for Vbb connection. PCB is vertical without blown air

³⁾ ESD susceptibility HBM according to EIA/JESD 22-A 114.



General Product Characteristics

4.2 Functional Range

Table 2 Functional Range

Parameter	Symbol	Values		Values		Note /	Number
		Min.	Тур.	Max.		Test Condition	
Nominal Operating Voltage	V_{S}	4.9	_	60	V	$V_{\rm S}$ increasing	4.2.1

Note: Within the functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.

4.3 Thermal Resistance

This thermal data was generated in accordance with JEDEC JESD51 standards. More information on www.jedec.org.

Table 3 Thermal Resistance¹⁾

Parameter	Symbol	Values			Unit	Note /	Number
		Min.	Тур.	Max.		Test Condition	
PG-SOT223-4			+		"	-	1
Junction to Case, Exposed pad	R_{thic}	_	40.5	_	K/W		4.3.1
Junction to ambient	R_{thJA_1s0p}	_	145.4	_	K/W	2)	4.3.2
Junction to ambient	R _{thJA_1s0p_300mm}	_	77.2	_	K/W	3)	4.3.3
Junction to ambient	R _{thJA_1s0p_600mm}		66.2	_	K/W	4)	4.3.4
Junction to ambient	R _{thJA 2s2p}	_	57.8	_	K/W	5)	4.3.5
Junction to ambient	R _{thJA 2s2pvia}	_	52.9	_	K/W	6)	4.3.6

¹⁾ Not subject to production test, specified by design

- 2) Specified R_{thJA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, footprint; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70 μ m Cu.
- 3) Specified $R_{\rm thJA}$ value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, Cu, 300mm²; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70 μ m Cu.
- 4) Specified $R_{\text{th,JA}}$ value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, 600mm²; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70 μ m Cu.
- 5) Specified R_{thJA} value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70 μ m Cu, 2 x 35 μ m Cu).
- 6) Specified R_{thJA} value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board with two thermal vias; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70μm Cu, 2 x 35μm Cu. The diameter of the two vias are equal 0.3mm and have a plating of 25um with a copper heatsink area of 3mm x 2mm). JEDEC51-7: The two plated-through hole vias should have a solder land of no less than 1.25 mm diameter with a drill hole of no less than 0.85 mm diameter.

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Electrical Characteristics

5 Electrical Characteristics

Table 4 $V_S = 9V$ to 60V; Tj = -40°C to 125°C; all voltages with respect to ground. Currents flowing into the device unless otherwise specified in chapter "Block Diagram and Terms". Typical values at Vs = 13.5V, Tj = 25°C

Parameter	Symbol	Values			Unit	Note /	Number
		Min. Typ.		Max.		Test Condition	
Powerstage	·						
NMOS ON Resistance	R_{DSON}	_	0.8	1.5	Ω	$I_{\rm OUT}$ = 150mA; $T_{\rm j}$ = 25°C; IN conected to GND	5.0.1
NMOS ON Resistance	R_{DSON}	_	1.5	3.0	Ω	$I_{\rm OUT}$ = 150mA; $T_{\rm j}$ = 125°C; IN conected to GND	5.0.2
NMOS ON Resistance	R_{DSON}	-	2	5	Ω	I_{OUT} = 50mA; T_{j} = 25°C; V_{S} = 6V; IN conected to GND	5.0.3
Nominal Load Current ¹⁾ ; device on PCB ²⁾	I_{LNOM}	0.2	_	_	А	$T_{\rm a}$ = 85°C; $T_{\rm j}$ = 125°C;	5.0.4
Timings of Power Stages	, , , , , , , , , , , , , , , , , , ,						
Turn ON Time $^{3)}$ (to 90% of $V_{\rm out}$); $V_{\rm S}$ to GND transition of $V_{\rm IN}$	t _{ON}	_	-	125 ⁴⁾	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω	5.0.5
Turn ON Time $^{3)}$ (to 90% of $V_{\rm out}$); $V_{\rm S}$ to GND transition of $V_{\rm IN}$	t _{ON}	-	45	100	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω ; $T_{\rm j}$ = 25°C	5.0.6
Turn OFF Time $^{3)}$ (to 10% of $V_{\rm out}$); GND to $V_{\rm S}$ transition of $V_{\rm IN}$	t_{OFF}	-	-	175 ⁴⁾	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω	5.0.7
Turn OFF Time $^{3)}$ (to 10% of $V_{\rm out}$); GND to $V_{\rm S}$ transition of $V_{\rm IN}$	t _{OFF}	-	40	140	μs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω ; $T_{\rm i}$ = 25°C	5.0.8
ON-Slew Rate $^{3)}$ (10 to 30% of $V_{\rm out}$); $V_{\rm S}$ to GND transition of $V_{\rm IN}$	SR_{ON}	_	-	6 4)	V / µs	$R_{\rm L} = 270\Omega$	5.0.9
ON-Slew Rate $^{3)}$ (10 to 30% of $V_{\rm out}$); $V_{\rm S}$ to GND transition of $V_{\rm IN}$	SR_{ON}	_	1.3	4.0	V/µs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω ; $T_{\rm j}$ = 25°C	5.0.10
OFF-Slew Rate $^{3)}$ (70 to 40% of $V_{\rm out}$); GND to $V_{\rm S}$ transition of $V_{\rm IN}$	SR_{OFF}	_	-	8 4)	V / µs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω	5.0.11
OFF-Slew Rate $^{3)}$ (70 to 40% of $V_{\rm out}$); GND to $V_{\rm S}$ transition of $V_{\rm IN}$ Standby current consumption	SR _{OFF}	_	1.7	4.0	V / µs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 270 Ω ; $T_{\rm j}$ = 25°C	5.0.12

Standby current consumption



Electrical Characteristics

Table 4 $V_S = 9V$ to 60V; Tj = -40°C to 125°C; all voltages with respect to ground. Currents flowing into the device unless otherwise specified in chapter "Block Diagram and Terms". Typical values at Vs = 13.5V, Tj = 25°C

Parameter	Symbol		Value	S	Unit	Note / Test Condition	Number
		Min.	Тур.	Max.			
Standby current	I_{SOFF}	_	2	10	μA	IN open	5.0.13
Protection functions ⁵⁾	1			<u> </u>	ļ.		
Initial peak short circuit current limit IN conected to GND	I_{LSCP}	_	-	1.2	A	$T_{\rm j}$ = -40°C; $V_{\rm S}$ = 13.5V $t_{\rm m}$ = 100 μ s	5.0.14
Initial peak short circuit current limit IN conected to GND	I_{LSCP}	-	0.9	-	A	$T_{\rm j}$ = 25°C; $V_{\rm S}$ = 13.5V $t_{\rm m}$ = 100 μ s	5.0.15
Initial peak short circuit current limit IN conected to GND	I_{LSCP}	0.2	-	-	A	$T_{\rm j}$ =125°C; $V_{\rm S}$ = 13.5V $t_{\rm m}$ = 100 μ s	5.0.16
Repetitive short circuit current limit IN conected to GND	I_{LSCR}	_	0.7	_	Α	_	5.0.17
Output clamp at $V_{\rm OUT}$ = $V_{\rm S}$ - $V_{\rm DSCL}$ (inductive load switch off)	V_{DSCL}	60	-	_	V	$I_{\rm S}$ = 4mA	5.0.18
Overvoltage protection	V_{SAZ}	62	68	_	V	$I_{\rm S}$ = 1mA	5.0.19
Thermal overload trip temperature ⁴⁾	T_{jTrip}	150	_	_	°C	_	5.0.20
Thermal hysteresis 4)	T_{HYS}		10	_	°C	_	5.0.21
Input interface		•	"				
Off state input current	I_{INOFF}	_	_	0.05	mA	$T_{\rm j}$ = -25°C; $R_{\rm L}$ = 270 Ω ; $V_{\rm OUT}$ =< 0.1V	5.0.22
Off state input current	I_{INOFF}	_	_	0.04	mA	$T_{\rm j}$ = 125°C; $R_{\rm L}$ = 270 Ω ; $V_{\rm OUT}$ =< 0.1V	5.0.23
On state input current; IN connected to GND ⁶⁾	I_{INON}	_	0.3	1.0	mA	_	5.0.24
Input resistance	R_{IN}	0.5	1.0	2.5	kΩ	_	5.0.25
Reverse Battery	· I	+	!	1	+	•	· ·
Continuous reverse drain current	I_{DREV}	_	_	0.2	Α	_	5.0.26
Forward voltage of the drain-source reverse diode	V_{FDS}	_	600	-	mV	$I_{\rm FDS}$ = 200mA $I_{\rm IN}$ =< 0.05mA	5.0.27

- 1) Nominal Load Current is limited by the current limitation; see protection function data
- 2) Device on 50mm x 50mm x 1,5mm epoxy FR4 PCB with 6cm² (one layer copper 70um thick) copper area for supply voltage connection. PCB in vertical position without blown air
- 3) Timing values only with high input slewrates ($t_{\rm rlN}$ = $t_{\rm flN}$ <= 50ns); otherwise slower
- 4) Not tested in production
- 5) Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.
- 6) Driver circuit must be able to sink currents > 1mA



6 Application Information

6.1 Application Diagram

The following information is given as a hint for the implementation of the device only and shall not be regarded as a description or warranty for a certain functionality, condition or quality of the device.

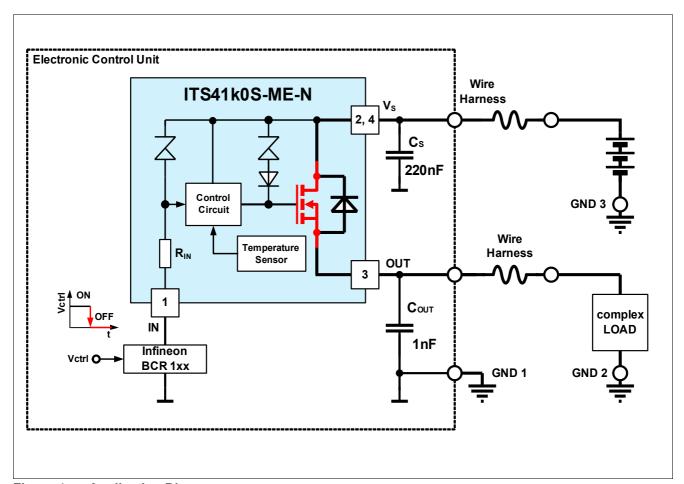


Figure 4 Application Diagram

The **ITS41k0S-ME-N** can be connected directly to a supply network. It is recommended to place a ceramic capacitor (e.g. $C_{\rm S}$ = 220nF) between supply and GND to avoid line disturbances. Wire harness inductors/resistors are sketched in the application circuit above.

The complex load (resistive, capacitive or inductive) must be connected to the output pin OUT.

A built-in current limit protects the device against destruction.

The ITS41k0S-ME-N can be switched on and off with a low power levelshifter switch e.g. Infineon BCR1xx.

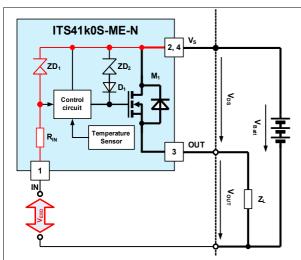
The IN pin must be pulled down to GND potential to switch the ITS41k0S-ME-N on. If no current is pulled down, the IN-node will float up to $V_{\rm S}$ potential by an internal pull up. In this mode the ITS41k0S-ME-N is deactivated with very low current consumption.

The output voltage slope is controlled during on and off transistion to minimize emissions. Only a small Cercap C_{OUT} =1nF is recommended to attenuate RF noise.

In the following chapters the main features, some typical waverforms and the protection behaviour of the **ITS41k0S-ME-N** is shown. For further details please refer to application notes on the Infineon homepage.

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6.2 Special features



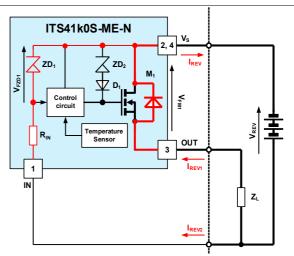
If Over-Voltage is applied to the V_S -Pin:

Voltage is limited to VZD1; Current can be calculated:

 $I_{ZD1} = (V_S - V_{ZD1}) / R_{IN}$

In case of ESD Pulse on the input pin there is in both polarities a peak current $I_{INpeak} \sim V_{ESD} / R_{IN}$

The control unit is protected in both cases by the Zenerdiode ZD1



If reverse Voltage is applied to the device:

1.) Current via Load Resistance RL:

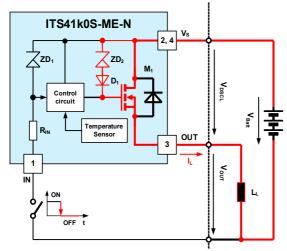
 $I_{Rev1} = (V_{REV} - V_{FM1}) / R_L$

2.) Current via Input Resistance RIN:

 $I_{REV2} = (V_{REV} - V_{FZD1}) / R_{IN}$

Both currents will sum up to:

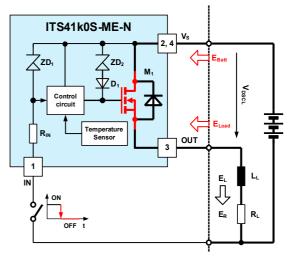
 $I_{REV} = I_{REV1} + I_{REV2}$



When an inductive load is switched off a current path must be established until the current is sloped down to zero (all energy removed from the inductive load). For that purpose the series combination ZD2 and D1 is connceted between Gate and Drain of the power DMOS.

When the device is switched off, the voltage at OUT turns negative until $V_{\mbox{\scriptsize DSCL}}$ is reached.

The Voltage on the incutive load is the difference between V_{DSCL} and $V_{\text{S}}.$



Energy stored in the load inductance is given by : $E_L = I_L^{2*}L/2$

While demagnetizing the load inductance the energy dissipated by the Power-DMOS is:

$$E_{AS} = E_S + E_L - E_R$$

With an approximate solution for $R_L > 0\Omega$:

 $E_{AS} = (I_L*L) / (2*R_L)*(V_S+V_{DSCL})*In((1+(I_L*R_L) / V_{DSCL})$

Figure 5 Special Feature descriptions

6.3 Typical Application Waveforms

General Input Output waveforms: Waveforms switching a resistive load: V_s V_{OUT} 4 90% V_{OUT} ♣ 40% toff OFF OFF ON ON OFF ON OFF Waveforms switching a capacitive load: Waveforms switching an inducitive load: V_{OUT} V_{OUT} ₽ $\mathbf{V}_{\mathbf{S}}$ $\ensuremath{ extsf{V}_{ extsf{S}}}$

Figure 6 Typical application waveforms

ON

OFF

ON

OFF

OFF

ON

OFF

ON

6.4 Protection behavior

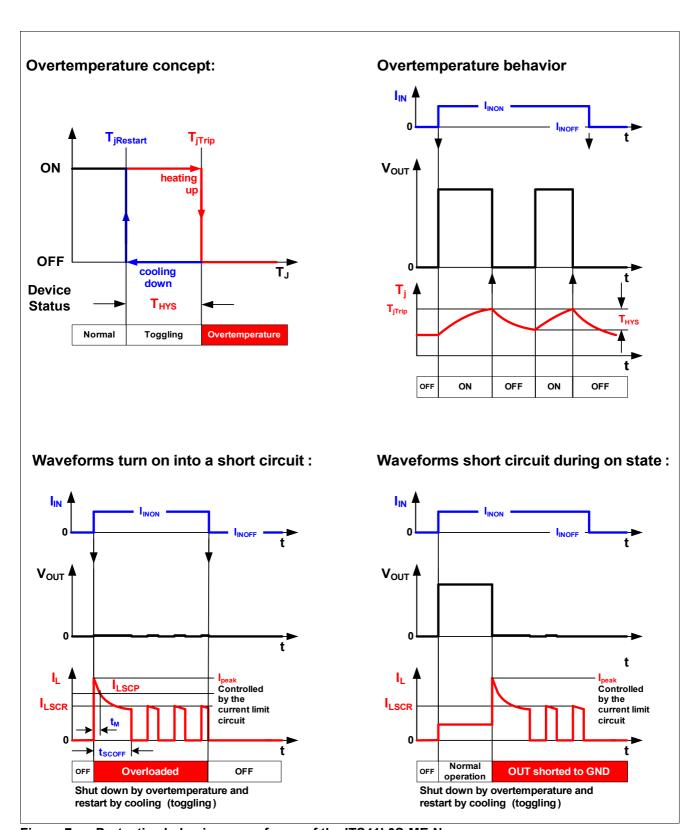


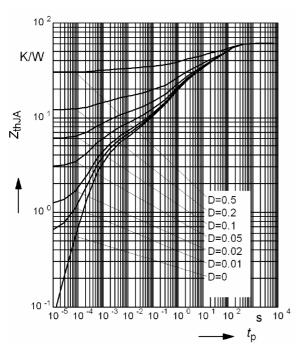
Figure 7 Protective behaviour waveforms of the ITS41k0S-ME-N



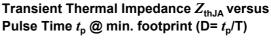
7 Typical Performance Graphs

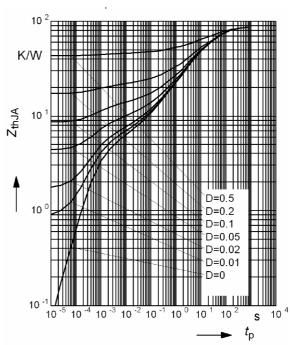
Typical Performance Characteristics

Transient Thermal Impedance $Z_{\rm thJA}$ versus Pulse Time $t_{\rm p}$ @ 6cm² heatsink area (D= $t_{\rm p}$ /T)

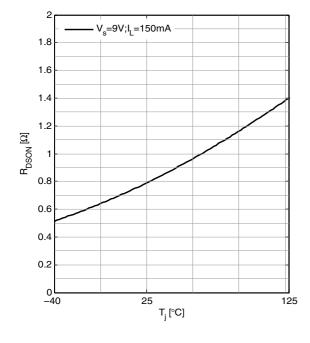


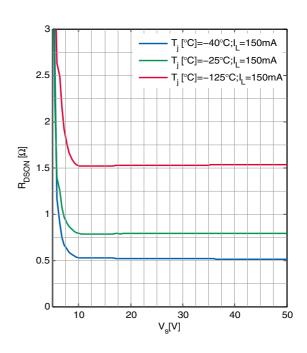
On-Resistance $R_{\rm DSON}$ versus Junction Temperature $T_{\rm J}$ @ = $V_{\rm S}$ = 9V; $I_{\rm L}$ =150mA





On-Resistance $R_{\rm DSON}$ versus Supply Voltage $V_{\rm S}$ = $V_{\rm bb}$ @ = $I_{\rm L}$ =150mA $T_{\rm i}$ =par.

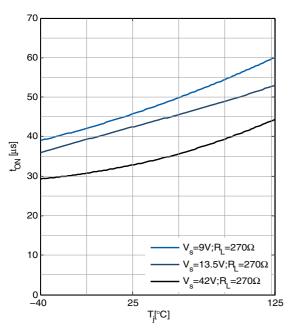




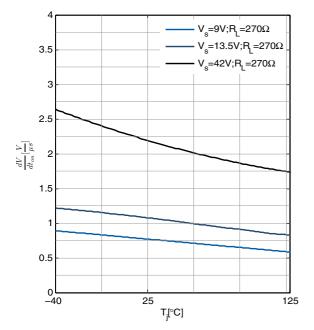


Typical Performance Characteristics

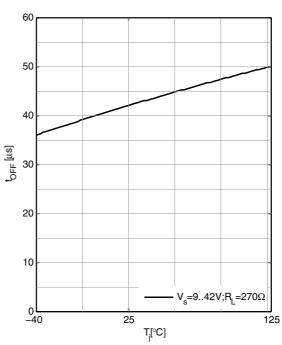
Switch ON Time $t_{\rm ON}$ versus Junction Temperature $T_{\rm J}$ @ = $R_{\rm L}$ = 270 Ω ; $V_{\rm S}$ =par.



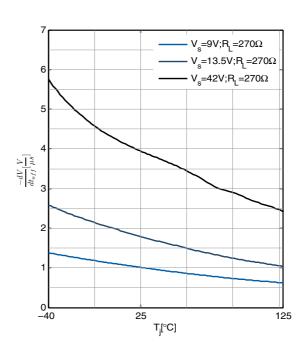
ON Slewrate $SR_{\rm ON}$ versus Junction Temperature $T_{\rm J}$ @ = $R_{\rm L}$ = 270 Ω ; $V_{\rm S}$ =par.



Switch OFF Time $t_{\rm OFF}$ versus Junction Temperature $T_{\rm J}$ @ = $R_{\rm L}$ = 270 Ω ; $V_{\rm S}$ =par.



OFF Slewrate $SR_{\rm OFF}$ versus Junction Temperature $T_{\rm J}$ @ = $R_{\rm L}$ = 270 Ω ; $V_{\rm S}$ =par.

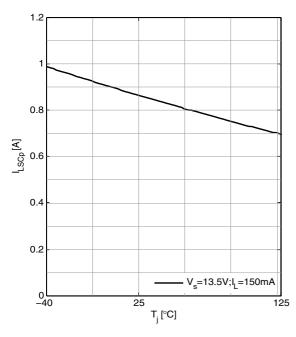


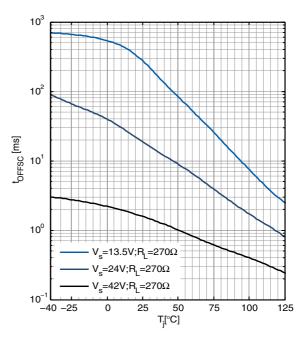


Typical Performance Characteristics

Initial Peak Short Circuit Current Limit $I_{\rm LSCP}$ versus Junction Temperature $T_{\rm J}$ @ $V_{\rm S}$ =13.5V; $t_{\rm m}$ =100 $\mu{\rm S}$

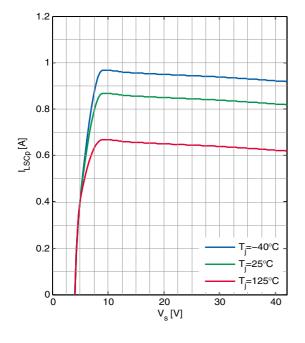
Initial Short Circuit Shutdown Time $t_{\rm OFF~SC}$ versus Junction Start-Temperature $T_{\rm JSTART}$; $V_{\rm S}$ =parameter

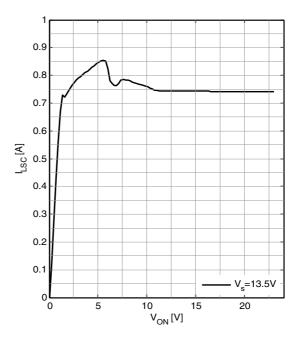




Initial Peak Short Circuit Current Limit $I_{\rm LSCP}$ versus Supply Voltage $V_{\rm S}$ = $V_{\rm bb}$ @ $T_{\rm i}$ =par.= 100 μ s.

Current Limitation Characteristic $I_{\rm LSC}$ versus Drain Source Voltage Drop $V_{\rm DS}$ @ $V_{\rm S}$ =13.5 V

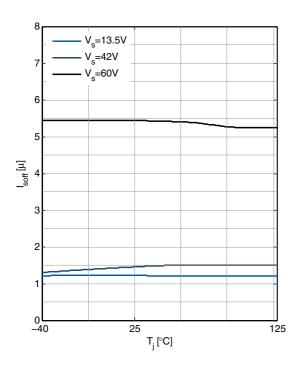






Typical Performance Characteristics

Stand By Current Consumption I_{SOFF} versus Junction Temperature T_{J} @ pin IN open





Package Outlines and Footprint

8 Package Outlines and Footprint

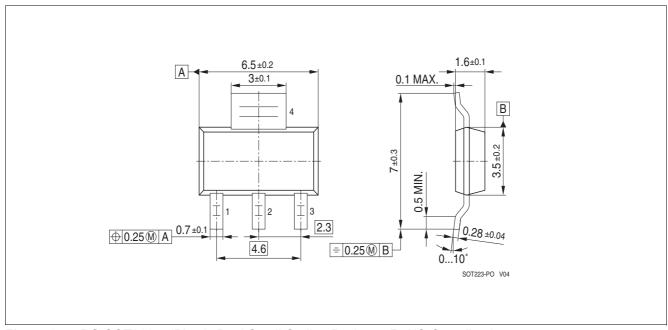


Figure 8 PG-SOT223-4 (Plastic Dual Small Outline Package, RoHS-Compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020



Revision History

9 Revision History

Revision	Date	Changes
1.0	2012-09-01	Datasheet release

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